

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at www.onsemi.com

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild guestions@onsemi.com.

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officer



FDFM2N111

Integrated N-Channel PowerTrench® MOSFET and Schottky Diode

General Description

FDFM2N111 combines the exceptional performance of Fairchild's PowerTrench MOSFET technology with a very low forward voltage drop Schottky barrier rectifier in a MicroFET package.

This device is designed specifically as a single package solution for Standard Buck Converter. It features a fast switching, low gate charge MOSFET with very low on-state resistance.

Applications

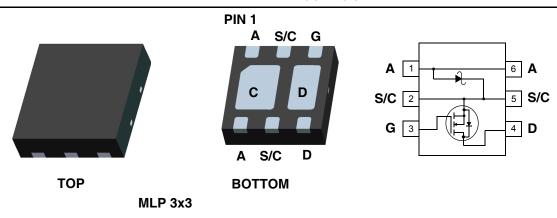
■ Standard Buck Converter

Features

■ 4 A, 20 V $R_{DS(ON)} = 100 \text{m}\Omega$ @ $V_{GS} = 4.5 \text{ V}$

 $R_{DS(ON)} = 150 \text{m}\Omega$ @ $V_{GS} = 2.5 \text{ V}$

■ Low Profile - 0.8 mm maximun - in the new package MicroFET 3x3 mm



Absolute Maximum Ratings $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage		±12	V
	Drain Current -Continuous	(Note 1a)	4	Α
D	-Pulsed		10	A
V _{RRM}	Schottky Repetitive Peak Reverse voltage		20	V
Io	Schottky Average Forward Current	(Note 1a)	2	Α
В	Power dissipation (Steady State)	(Note 1a)	1.7	W
P_{D}	Power dissipation (Steady State)	(Note 1b)	0.8	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	70	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	150	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
2N111	FDFM2N111	7inch	12mm	3000 units

Electrical Characteristics $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
B _{VDSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	20	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	12	1	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} = 0V, V _{DS} = 16V	-	-	1	μΑ
I _{GSS}	Gate-Body Leakage,	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics (Note 2)

V _{GS(TH)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6	1.0	1.5	V
$\frac{\Delta V_{GS(TH)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	-3	-	mV/°C
		$I_D = 4.0A, V_{GS} = 4.5V$	-	54	100	
R _{DS(ON)}	Static Drain-Source On-Resistance	$I_D = 3.3A, V_{GS} = 2.5V$	-	83	150	mΩ
DS(ON)	Statio Brain Course on Tresionarios	$I_D = 4.0A, V_{GS} = 4.5V,$ $T_J = 125^{\circ}C$	-	74	147	11132
I _{D(ON)}	On-State Drain Current	$V_{GS} = 2.5V, V_{DS} = 5V$	10	-	-	Α
9 _{FS}	Forward Transconductance	$I_D = 4A$, $V_{DS} = 5V$	-	9.7	_	S

Dynamic Characteristics

C _{ISS}	Input Capacitance	10// // 0//	-	273	-	pF
Coss	Output Capacitance	V _{DS} = 10V, V _{GS} = 0V, f = 1MHz	-	63	-	pF
C _{RSS}	Reverse Transfer Capacitance	T = 1MHZ	-	37	-	pF
R_G	Gate Resistance	$V_{GS} = 0V, f = 1MHz,$	-	1.6	•	Ω

Switching Characteristics (Note 2)

t _{d(ON)}	Turn-On Delay Time		-	6	12	ns
t _r	Turn-On Rise Time	V _{DD} = 10V, I _D = 1A	-	7	14	ns
t _{d(OFF)}	Turn-Off Delay Time	$V_{GS} = 4.5V$, $R_{GEN} = 6\Omega$	-	11	20	ns
t _f	Turn-Off Fall Time		-	1.7	3.4	ns
Q_g	Total Gate Charge	V 10V L 10A	-	2.7	3.8	nC
Q_{gs}	Gate-Source Charge	$V_{DS} = 10V, I_{D} = 4.0A,$ $V_{GS} = 4.5V$	-	0.6	-	nC
Q_{gd}	Gate-Drain Charge	VGS - 4.5 V	-	0.9	-	nC

Drain-Source Diode Characteristics and Maximum Ratings

Is	Maximum Continuous Drain-Source Diode Forward Current		-	-	1.4	Α
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0V, I_S = 1.4 \text{ A (Note 2)}$	-	0.8	-1.2	V
t _{rr}	Diode Reverse Recovery Time	-I _E = 4.0A, dI _E /dt=100A/μs	-	11	-	ns
Q _{rr}	Diode Reverse Recovery Charge	-1 _F = 4.0A, di _F /di=100A/μs	-	3	-	nC

Schottky Diode Characteristic

V_{R}	Reverse Voltage	I _R = 1mA		20	-	-	V
1_	Reverse Leakage	V 5V	$T_J = 25^{\circ}C$	_		100	μΑ
^I R	neverse Leakage	$V_R = 5V$	$T_J = 100^{\circ}C$	-	-	10	mA
V_{F}	Forward Voltage	I _F = 1A	$T_J = 25^{\circ}C$	-	0.32	0.39	V

Electrical Characteristics $T_A = 25$ °C unless otherwise noted

Notes

1. $R_{\theta,JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta CA}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



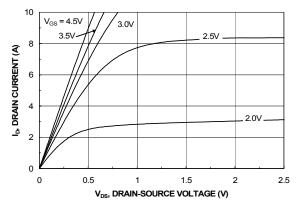
a) 70°C/W when mounted on a 1in² pad of 2 oz copper



- b) 150°C/W whe mounted on a minimum pad of 2 oz copper
- Scale 1: 1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

Typical Characteristics



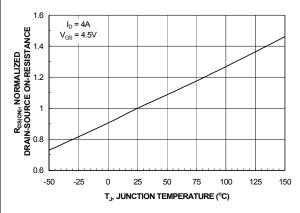
PROBLES 1.8

ORANGE SISTANCE

ORANGE SIS

Figure 1. On-Region Characteristics

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage



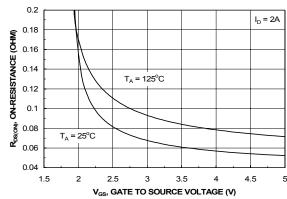
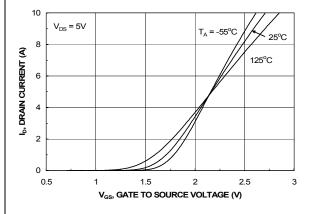


Figure 3. On-Resistance Variation with Temperature

Figure 4. On-Resistance Variation with Gate-to-Source Voltage



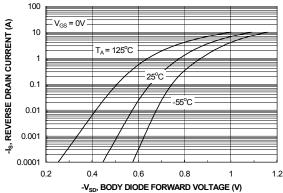


Figure 5. Transfer Characteristics

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

Typical Characteristics

0

0

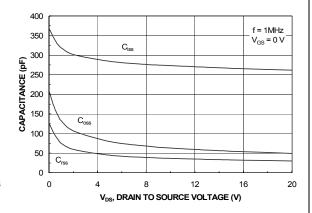
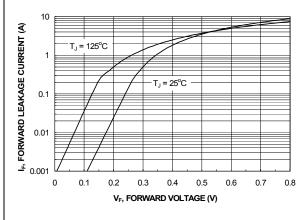


Figure 7. Gate Charge Characteristics

Qg, GATE CHARGE (nC)

Figure 8. Capacitance Characteristics



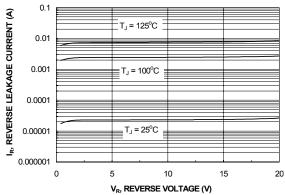


Figure 9. Schottky Diode Forward Voltage

Figure 10. Schottky Diode Reverse Current

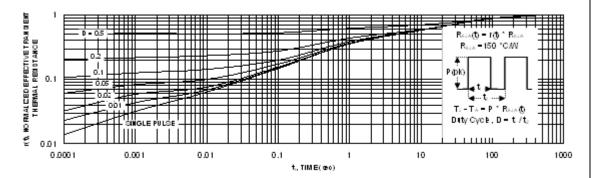
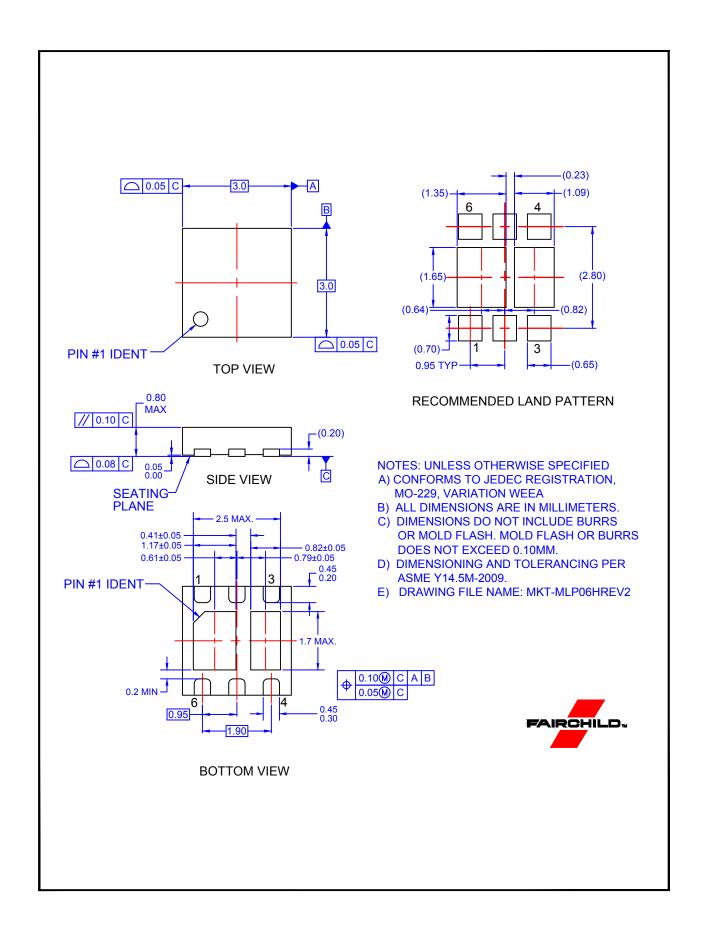


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.



ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdt/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and exp

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

ON Semiconductor: FDFM2N111